



ePIC pfRICH Aerogel QA Progress Report

Matt Posik Temple University



□Aerogel Factory n=1.02 tiles

Aerogel QA Procedure

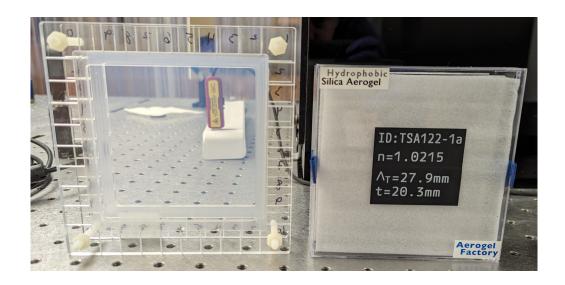


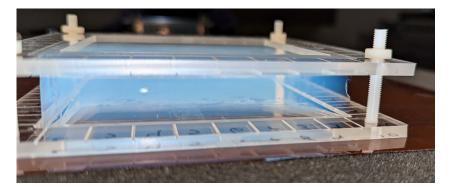
□Aerogel Factory n=1.02 tiles

Aerogel QA Procedure



Type	n=1.02	n=1.02	n=1.02	n=1.02	n=1.02
Serial number	TSA122-1a	TSA122-2a	TSA122-2b	TSA153-2	TSA153-3
Refractive index (at 405 nm)	1.0215	1.0215	1.0215	1.0215	1.0223
Transmission length (at 400 nm) [mm]	27.9	33.3	34.1	28.0	30.0
Transmittance (at 400 nm) [%]	48.4	54.7	55.7	49.0	51.5
Lateral tile size (nominal) [mm]	107.1	107.2	107.1	107.5	106.8
Thickness (nominal) [mm]	20.3	20.1	19.9	20.0	19.9
Weight [g]	18.59	18.62	18.37	18.36	18.56
Density [g/cm ³]	0.080	0.081	0.080	0.079	0.082
Appearance	Good	Good	Good	Good	Good
File name of transmittance data [.txt]	tsa122-1a	tsa122-2a	tsa122-2b	tsa153-2	tsa153-3









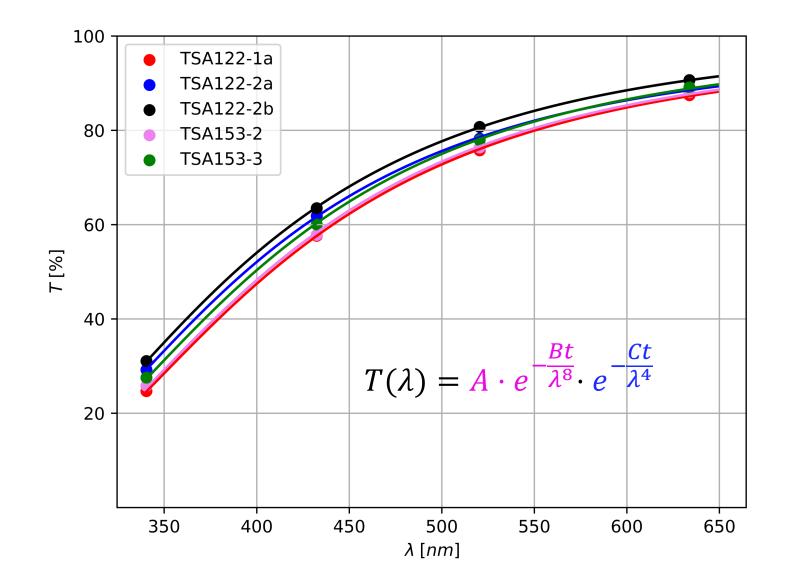
Agree with Aerogel Factory specs

Index of refraction results. TU average of four corner measurements.

Tile	Measurement Source	LED λ [nm]	n	(AF – TU)/AF [%]
TSA122-1a	Aerogel Factory	405	1.0215	
	Temple	403	1.0216 +/- 0.0026	0.013
TSA122-2a	Aerogel Factory	405	1.0215	
	Temple	403	1.0215 +/- 0.0026	0.002
TSA122-2b	Aerogel Factory	405	1.0215	
	Temple	403	1.0215 +/- 0.0026	0.002
TSA153-2	Aerogel Factory	405	1.0215	
	Temple	403	1.0219 +/- 0.0026	0.048
TSA153-3	Aerogel Factory	405	1.0223	
	Temple	403	1.0229 +/- 0.0026	0.060



□ n = 1.02 Aerogel Factory Tiles Transmittance





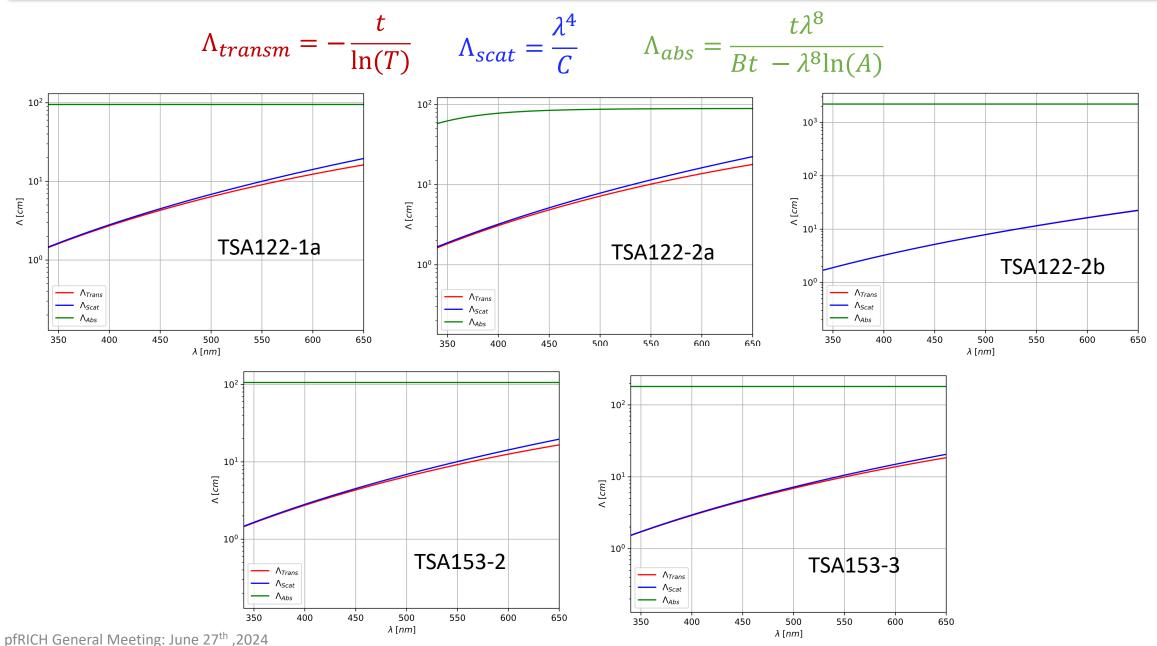
- □ B parameter found to be ~0
 - > Will investigate further

Hunt extended formula fit parameter results from TU measurements.

Tile	t [cm]	A	$B\left[\frac{\mu m^8}{cm}\right]$	$C\left[rac{\mu m^4}{cm} ight]$
TSA122-1a	2.03	0.9789 ± 0.0173	$10^{-24} \pm 1.08 \times 10^{-5}$	0.0091 ± 0.0008
TSA122-2a	2.01	0.9778 ± 0.0168	$1.09 \times 10^{-6} \pm 9.96 \times 10^{-6}$	0.0080 ± 0.0007
TSA122-2b	1.99	0.9991 ± 0.0167	$10^{-25} \pm 9.70 \times 10^{-6}$	0.0079 ± 0.0007
TSA153-2	2.00	0.9814 ± 0.0172	$10^{-23} \pm 1.075 \times 10^{-5}$	0.0091 ± 0.0008
TSA153-3	1.99	0.9890 ± 0.0170	$10^{-24} \pm 1.037 \times 10^{-5}$	0.0087 ± 0.0008

Lengths

epi



8



> Within uncertainties of Aerogel Factory specs

Lengths calculated from TU fit results at $\lambda = 400 \ nm$.

Tile	t [cm]	T[%] (TU)	T[%] (AF)	Λ _{Transm} [cm] (TU)	Λ _{Transm} [cm] (AF)
TSA122-1a	2.03	47.44 ± 3.45	48.4	2.722 ± 0.131	2.79
TSA122-2a	2.01	52.07 ± 3.57	54.7	3.080 ± 0.161	3.33
TSA122-2b	1.99	54.03 ± 3.59	55.7	3.232 ± 0.175	3.41
TSA153-2	2.00	48.22 ± 3.47	49.0	2.742 ± 0.135	2.80
TSA153-3	1.99	50.31 <u>+</u> 3.51	51.5	2.897 ± 0.148	3.00



Aerogel Factory n=1.02 tiles

Aerogel QA Procedure



- 1. Properties of each Aerogel tile that needs to be determined
- 2. Process/procedures of how these parameters are determined
- 3. Experimental setup with which these parameters are measured
- 4. Bookkeeping: how we plan to collect, retain, store the information and make them accessible



- 1. Properties of each Aerogel tile that needs to be determined
 - a. Visual inspection (e.g. cracks, marks ...)
 - b. Dimensions and weight
 - c. Planarity touch probes? Reference frame?
 - d. Transmittance and its uniformity, fit parameters \rightarrow Transmission length, scattering length, absorption length
 - e. Index of refraction, variation of n

Acceptable tolerances will need to be worked out for all QA quantities

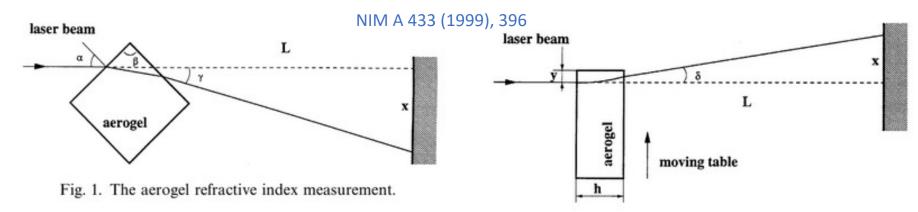


Fig. 2. The aerogel refractive index variation measurement.



- 2. Process/procedures of how these parameters are determined
- 3. Experimental setup with which these parameters are measured
- 4. Bookkeeping: how we plan to collect, retain, store the information and make them accessible
 - Will use database to track aerogel location, ID, measurement results, implement pass/fail checks based on tolerances ...
 - Database software still TBD, but <u>DB requirement document</u> ensures proper bookkeeping will be available



□ Measured Aerogel Factory n=1.02 tiles (5 tiles)

- Measured index of refraction (via prism method) and transmittance
- TU measurements found to be consistent (within uncertainties) with Aerogel Factory specs
- □ Continue investigating transmittance fitting procedure
- □ Investigate n variation measurement setup
- □ Follow up with QA procedures

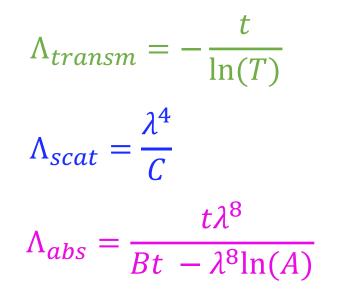


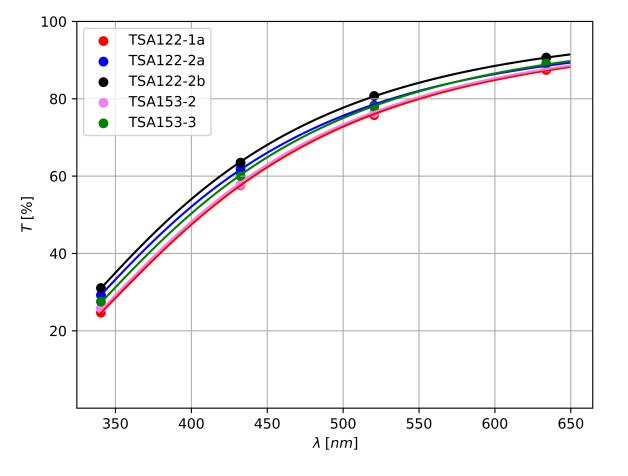
Fit Transmittance



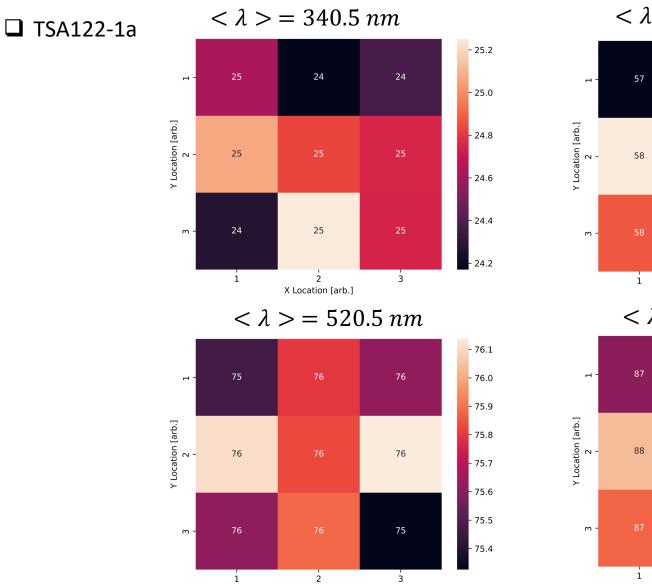
Hunt Extended Formula

$$T(\lambda) = e^{-\frac{t}{\Lambda_{transm}}} = e^{-t\left(\frac{1}{\Lambda_{abs}} + \frac{1}{\Lambda_{scat}}\right)} = A \cdot e^{-\frac{Bt}{\lambda^8}} \cdot e^{-\frac{Ct}{\lambda^4}}$$



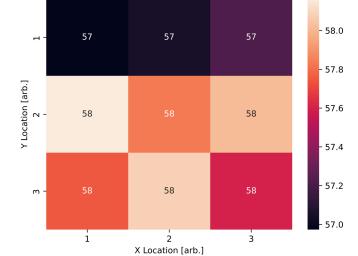


epi

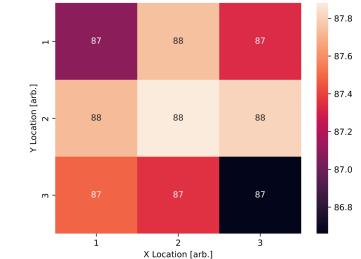


X Location [arb.]

$<\lambda>=432.4$ nm



 $<\lambda> = 633.8 \, nm$



ePI

- 63

- 62

- 61

- 60

- 59

- 90

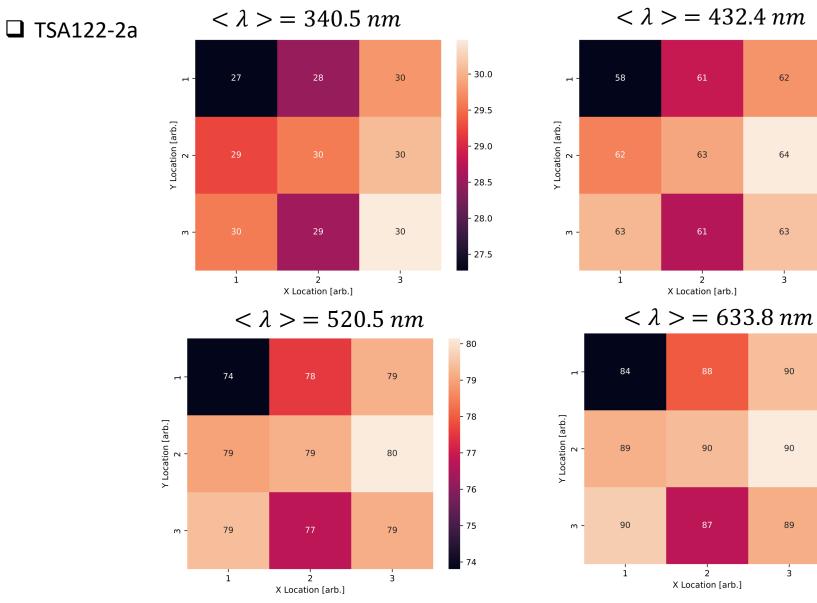
- 89

- 88

- 87

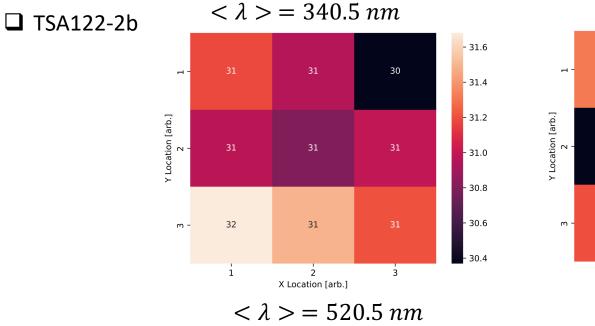
- 86

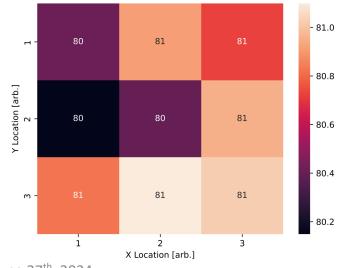
- 85

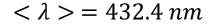


pfRICH General Meeting: June 27th ,2024

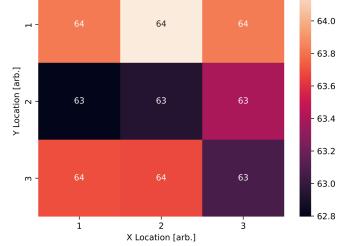




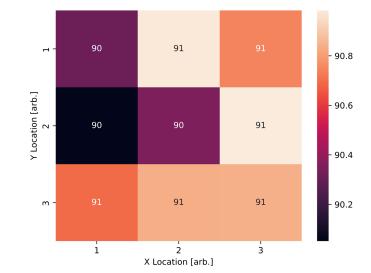




- 64.2



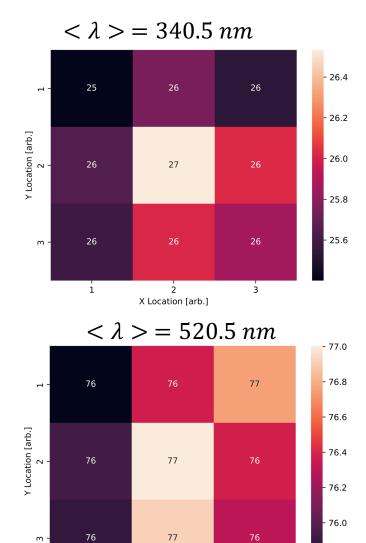
 $<\lambda>=633.8~nm$



pfRICH General Meeting: June 27th ,2024





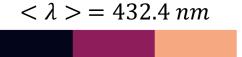


2

X Location [arb.]

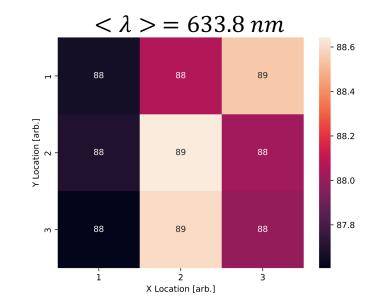
- 75.8

ż



- 58.4

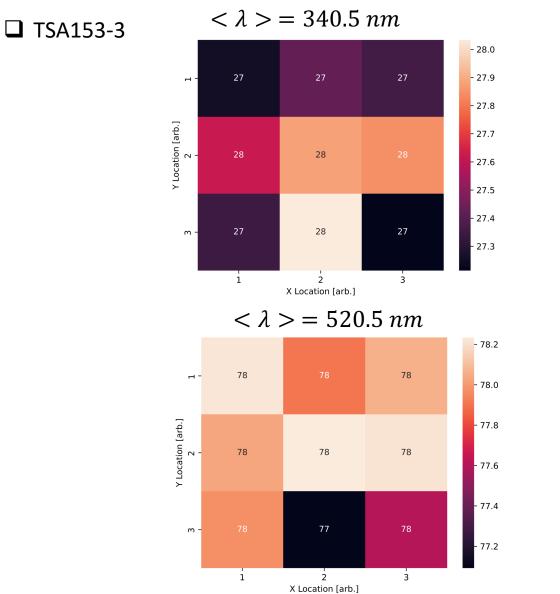




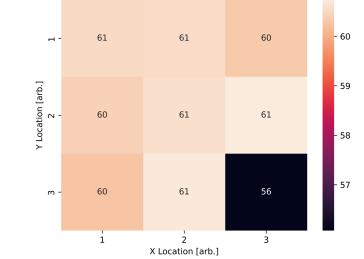
pfRICH General Meeting: June 27th ,2024

1

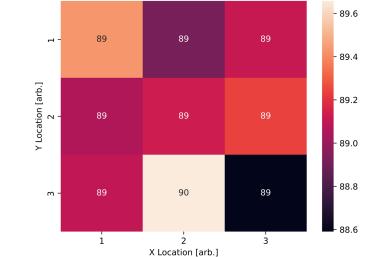
ePI



 $<\lambda> = 432.4 \, nm$



 $<\lambda> = 633.8 \, nm$



pfRICH General Meeting: June 27th, 2024